

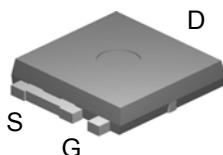
**AOL1444**
**N-Channel Enhancement Mode Field Effect Transistor**
**General Description**

The AOL1444 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , shoot-through immunity and body diode characteristics. This device is ideally suited for use as a low side switch in CPU core power conversion. *Standard Product AOL1444 is Pb-free (meets ROHS & Sony 259 specifications). AOL1444L is a Green Product ordering option. AOL1444 and AOL1444L are electrically identical.*

**Features**

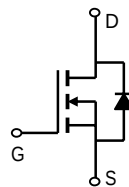
$V_{DS} (V) = 30V$   
 $I_D = 85A (V_{GS} = 10V)$   
 $R_{DS(ON)} < 4.3m\Omega (V_{GS} = 10V)$   
 $R_{DS(ON)} < 6.3m\Omega (V_{GS} = 4.5V)$

Ultra SO-8™ Top View



Bottom tab  
connected to  
drain

**Fits SOIC8  
footprint !**


**Absolute Maximum Ratings  $T_A=25^\circ C$  unless otherwise noted**

| Parameter                               | Symbol            | Maximum    | Units      |
|-----------------------------------------|-------------------|------------|------------|
| Drain-Source Voltage                    | $V_{DS}$          | 30         | V          |
| Gate-Source Voltage                     | $V_{GS}$          | $\pm 20$   | V          |
| Continuous Drain Current <sup>B,G</sup> | $I_D$             | 85         | A          |
| $T_C=25^\circ C^G$                      |                   | 73         |            |
| $T_C=100^\circ C^B$                     |                   |            |            |
| Pulsed Drain Current                    | $I_{DM}$          | 200        |            |
| Continuous Drain Current <sup>G</sup>   | $I_{DSM}$         | 17         | A          |
| $T_A=25^\circ C$                        |                   | 13         |            |
| $T_A=70^\circ C$                        |                   |            |            |
| Avalanche Current <sup>C</sup>          | $I_{AR}$          | 30         | A          |
| Repetitive avalanche energy $L=0.1mH^C$ | $E_{AR}$          | 45         | mJ         |
| Power Dissipation <sup>B</sup>          | $T_C=25^\circ C$  | 100        | W          |
|                                         | $T_C=100^\circ C$ | 50         |            |
| Power Dissipation <sup>A</sup>          | $T_A=25^\circ C$  | 2.1        | W          |
|                                         | $T_A=70^\circ C$  | 1.3        |            |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$    | -55 to 175 | $^\circ C$ |

**Thermal Characteristics**

| Parameter                                | Symbol          | Typ  | Max | Units        |
|------------------------------------------|-----------------|------|-----|--------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 19.6 | 25  | $^\circ C/W$ |
| $t \leq 10s$                             |                 |      |     |              |
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JC}$ | 48   | 60  | $^\circ C/W$ |
| Steady-State                             |                 |      |     |              |
| Maximum Junction-to-Case <sup>C</sup>    |                 | 1    | 1.5 | $^\circ C/W$ |
| Steady-State                             |                 |      |     |              |

Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol                      | Parameter                             | Conditions                                                                                 | Min  | Typ        | Max        | Units |
|-----------------------------|---------------------------------------|--------------------------------------------------------------------------------------------|------|------------|------------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                            |      |            |            |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                                 | 30   |            |            | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =24V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |      | 0.005      | 1<br>5     | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V                                                |      |            | 100        | nA    |
| V <sub>GS(t)</sub>          | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =250μA                                     | 1.45 | 1.8        | 3          | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                                  | 200  |            |            | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                         |      | 3.2<br>4.3 | 4.3<br>5.2 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =20A                                                 |      | 4.9        | 6.3        | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =20A                                                   |      | 85         |            | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                    |      | 0.7        | 1          | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                            |      |            | 85         | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                            |      |            |            |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                                          |      | 6070       | 7000       | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                            |      | 638        |            | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                            |      | 375        |            | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                           |      | 0.45       | 0.6        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                            |      |            |            |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                     | V <sub>GS</sub> =4.5V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                           |      | 96.4       | 115        | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                     |                                                                                            |      | 46.4       | 55         | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                            |      | 13.6       |            | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                            |      | 15.6       |            | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |      | 15.7       | 21         | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                            |      | 14.2       | 21         | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                            |      | 55.5       | 75         | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                            |      | 14         | 21         | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =20A, dI/dt=100A/μs                                                         |      | 31         | 38         | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =20A, dI/dt=100A/μs                                                         |      | 24         | 29         | nC    |

A: The value of R<sub>θJA</sub> is measured with the device in a still air environment with T<sub>A</sub>=25°C.

B: The power dissipation PD is based on T<sub>J</sub>(MAX)=175°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature T<sub>J</sub>(MAX)=175°C.

D: The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.

E: The static characteristics in Figures 1 to 6 are obtained using <300 ms pulses, duty cycle 0.5% max.

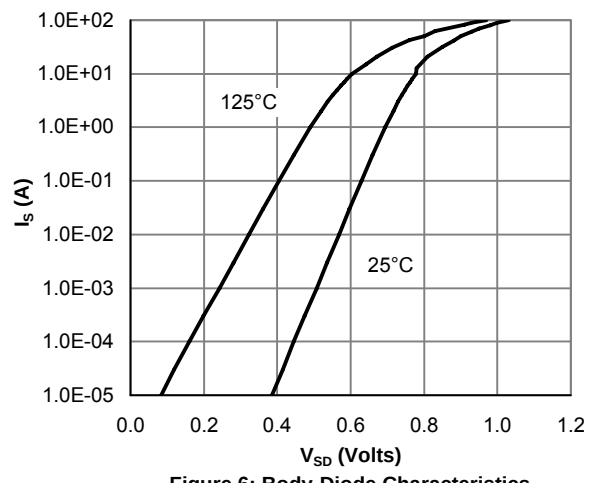
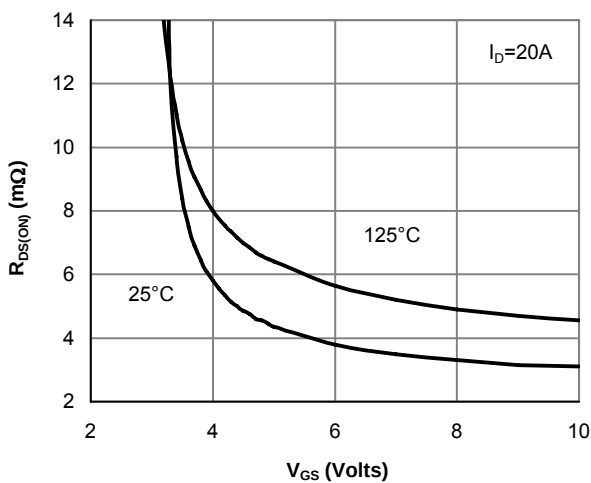
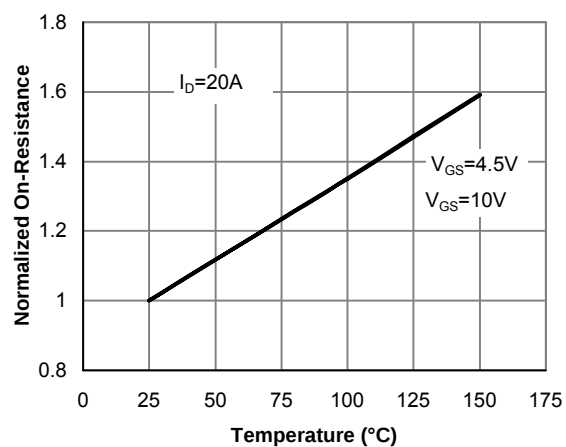
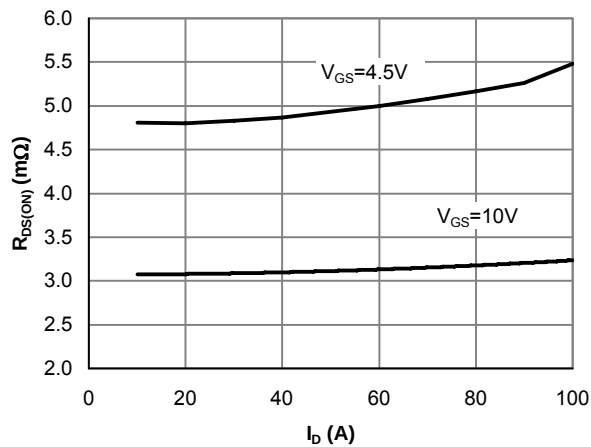
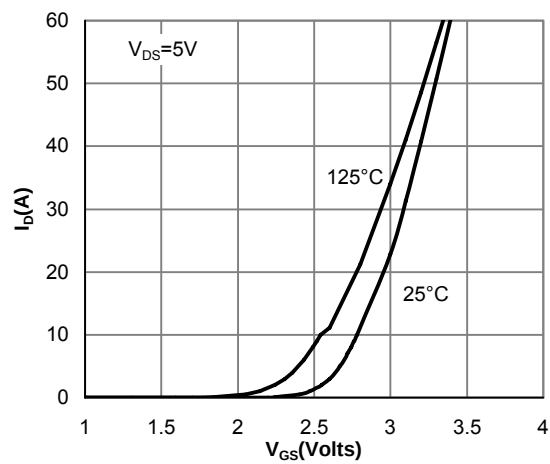
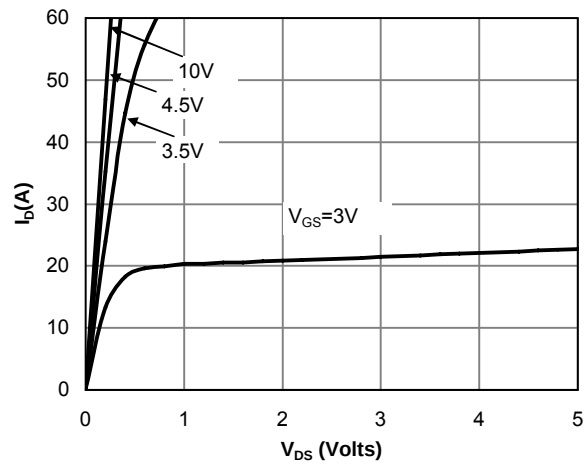
F: These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J</sub>(MAX)=175°C.

G: Surface mounted on a 1 in 2 FR-4 board with 2oz. Copper.

H: These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The SOA curve provides a single pulse rating. Rev0. Dec 2005

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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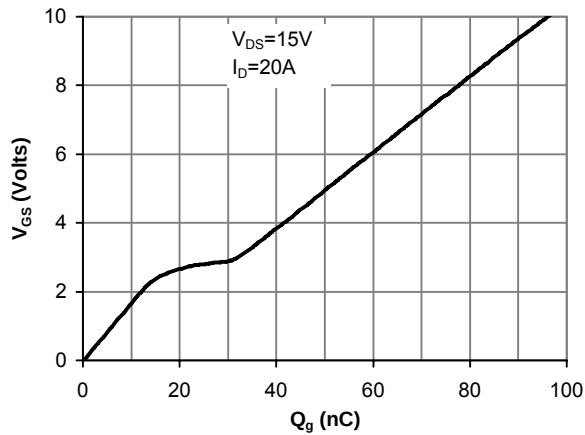


Figure 7: Gate-Charge Characteristics

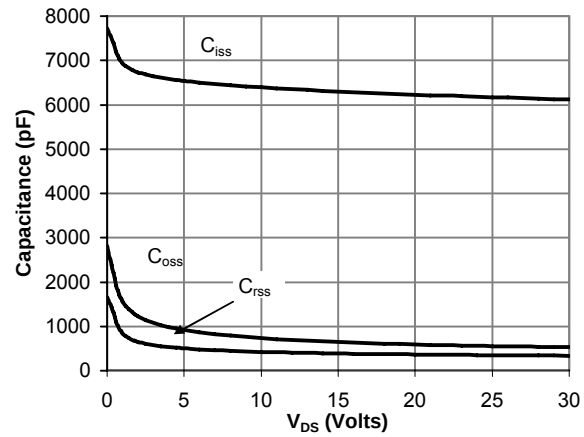


Figure 8: Capacitance Characteristics

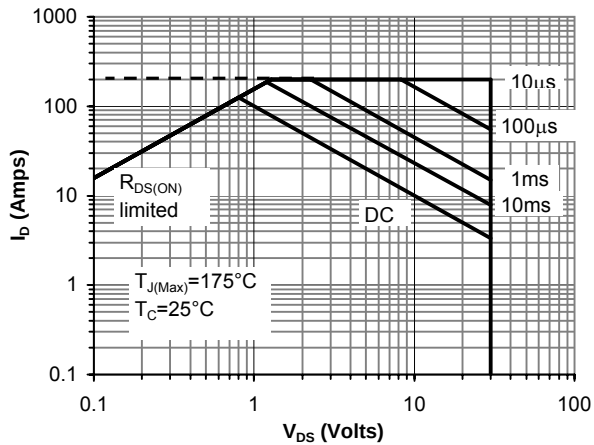


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

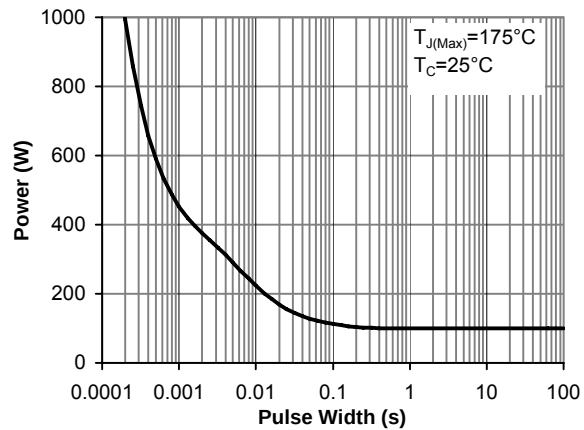


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

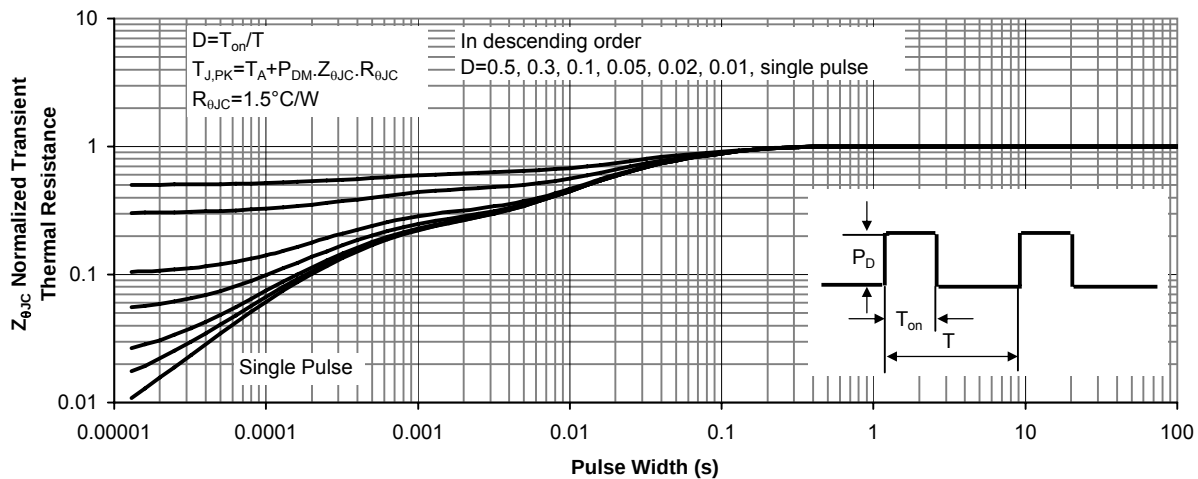


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

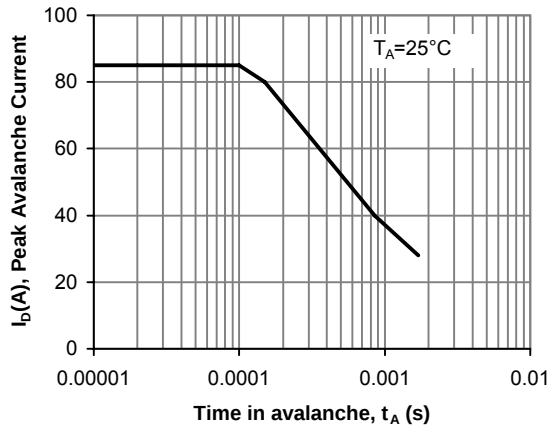


Figure 12: Single Pulse Avalanche capability

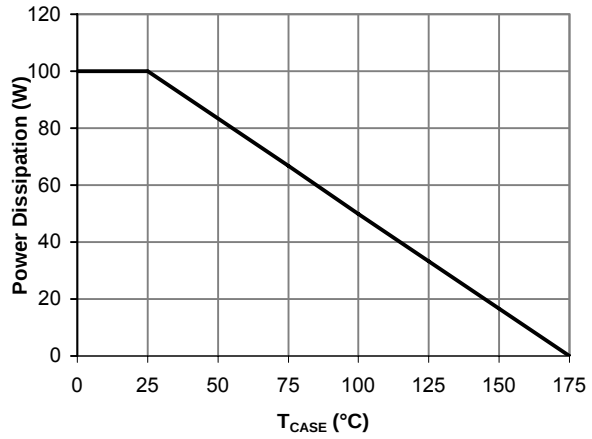


Figure 13: Power De-rating (Note B)

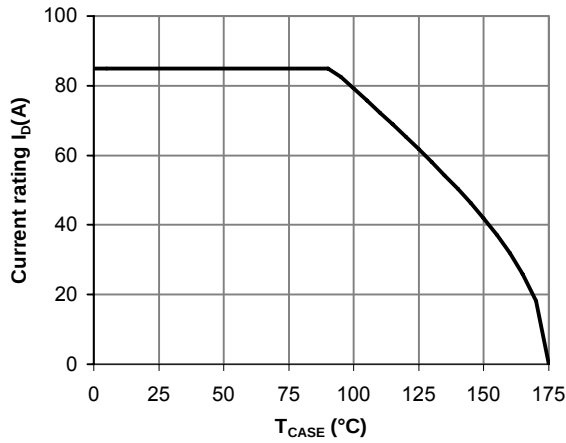


Figure 14: Current De-rating (Note B)

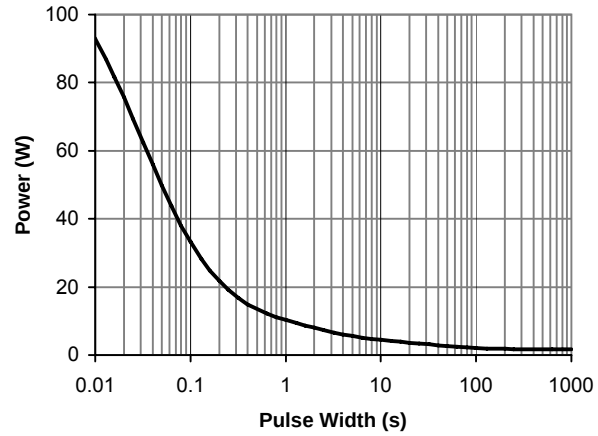


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

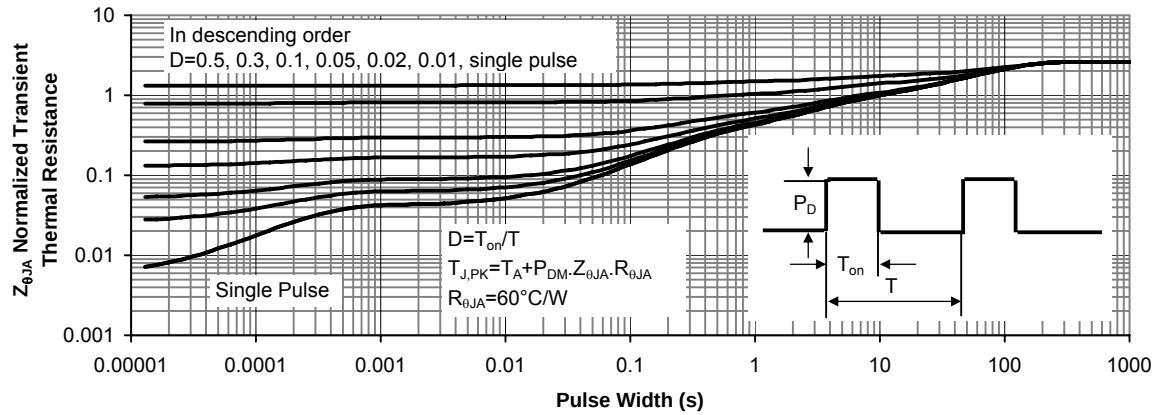


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)